# Self-Protected Low Side Driver with Temperature and Current Limit

NCV8405/A is a three terminal protected Low–Side Smart Discrete device. The protection features include overcurrent, overtemperature, ESD and integrated Drain–to–Gate clamping for overvoltage protection. This device is suitable for harsh automotive environments.

### **Features**

- Short-Circuit Protection
- Thermal Shutdown with Automatic Restart
- Overvoltage Protection
- Integrated Clamp for Inductive Switching
- ESD Protection
- dV/dt Robustness
- Analog Drive Capability (Logic Level Input)
- NCV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q100 Qualified and PPAP Capable
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

### **Typical Applications**

- Switch a Variety of Resistive, Inductive and Capacitive Loads
- Can Replace Electromechanical Relays and Discrete Circuits
- Automotive / Industrial

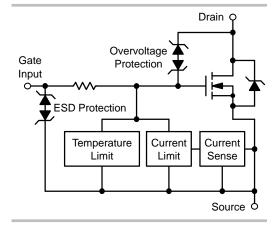


## ON Semiconductor®

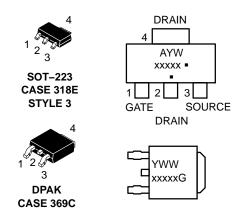
### www.onsemi.com

V <sub>(BR)DSS</sub> (Clamped)	R <sub>DS(ON)</sub> TYP	I <sub>D</sub> MAX
42 V	90 mΩ @ 10 V	6.0 A*

<sup>\*</sup>Max current limit value is dependent on input condition.



## MARKING DIAGRAM



A = Assembly Location

Y = Year

W, WW = Work Week

xxxxx = V8405 or 8405A G or = Pb-Free Package

(Note: Microdot may be in either location)

## **ORDERING INFORMATION**

See detailed ordering and shipping information in the package dimensions section on page 10 of this data sheet.

## **MAXIMUM RATINGS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Rati	Symbol	Value	Unit	
Drain-to-Source Voltage Internally Clamped	$V_{DSS}$	42	V	
Drain-to-Gate Voltage Internally Clamped	$(R_G = 1.0 M\Omega)$	$V_{DGR}$	42	V
Gate-to-Source Voltage		V <sub>GS</sub>	±14	V
Continuous Drain Current		I <sub>D</sub>	Internally Limited	
Power Dissipation – SOT–223 Version  Power Dissipation – DPAK Version	@ T <sub>A</sub> = 25°C (Note 1) @ T <sub>A</sub> = 25°C (Note 2) @ T <sub>S</sub> = 25°C @ T <sub>A</sub> = 25°C (Note 1) @ T <sub>A</sub> = 25°C (Note 2) @ T <sub>S</sub> = 25°C	P <sub>D</sub>	1.0 1.7 11.4 2.0 2.5 40	W
Thermal Resistance – SOT–223 Version  Thermal Resistance – DPAK Version	Junction-to-Ambient Steady State (Note 1) Junction-to-Ambient Steady State (Note 2) Junction-to-Soldering Point Steady State  Junction-to-Ambient Steady State (Note 1) Junction-to-Ambient Steady State (Note 2) Junction-to-Soldering Point Steady State	R <sub>θJA</sub> R <sub>θJA</sub> R <sub>θJA</sub> R <sub>θJA</sub> R <sub>θJA</sub> R <sub>θ</sub> JS	130 72 11 60 50 3.0	°C/W
Single Pulse Drain–to–Source Avalanche Energy (V <sub>DD</sub> = 40 V, V <sub>G</sub> = 5.0 V, I <sub>PK</sub> = 2.8 A, L = 80 mH, R <sub>G(ext)</sub> = 25 $\Omega$ , TJ = 25°C)			275	mJ
Load Dump Voltage $V_{LD} = V_A + V_S (V_{GS} = 0 \text{ and } 10 \text{ V}, R_I = 2.0 \Omega, R_L = 6.0 \Omega, t_d = 400 \text{ ms})$			53	V
Operating Junction Temperature			-40 to 150	°C
Storage Temperature			-55 to 150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Surface—mounted onto min pad FR4 PCB, (2 oz. Cu, 0.06" thick).

2. Surface—mounted onto 2" sq. FR4 board (1" sq., 1 oz. Cu, 0.06" thick).

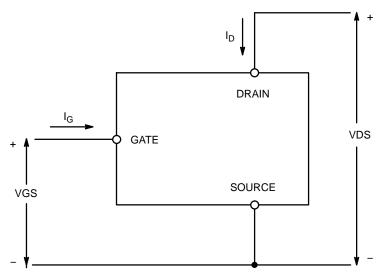


Figure 1. Voltage and Current Convention

# **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Test Condition	Symbol	Min	Тур	Max	Unit
	1001 00112111011	<b> </b>		.76		J
OFF CHARACTERISTICS  Drain-to-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 10 \text{ mA}, T_J = 25^{\circ}\text{C}$	V(pp)poo	42	46	51	V
(Note 3)	$V_{GS} = 0 \text{ V}, I_D = 10 \text{ mA}, T_J = 25 \text{ °C}$	$V_{(BR)DSS}$	42	45	51	-
	(Note 5)		42	43	31	
Zero Gate Voltage Drain Current	$V_{GS} = 0 \text{ V}, V_{DS} = 32 \text{ V}, T_{J} = 25^{\circ}\text{C}$	I <sub>DSS</sub>		0.5	2.0	μΑ
	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 32 V, T <sub>J</sub> = 150°C (Note 5)			2.0	10	
Gate Input Current	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = 5.0 V	I <sub>GSSF</sub>		50	100	μΑ
ON CHARACTERISTICS (Note 3)						
Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 150 \mu A$	V <sub>GS(th)</sub>	1.0	1.6	2.0	V
Gate Threshold Temperature Coefficient		V <sub>GS(th)</sub> /T <sub>J</sub>		4.0		-mV/°C
Static Drain-to-Source On-Resistance	$V_{GS} = 10 \text{ V}, I_D = 1.4 \text{ A}, T_J = 25^{\circ}\text{C}$	R <sub>DS(on)</sub>		90	100	mΩ
	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 1.4 A, T <sub>J</sub> = 150°C (Note 5)			165	190	
	V <sub>GS</sub> = 5.0 V, I <sub>D</sub> = 1.4 A, T <sub>J</sub> = 25°C			105	120	
	V <sub>GS</sub> = 5.0 V, I <sub>D</sub> = 1.4 A, T <sub>J</sub> = 150°C (Note 5)			185	210	
	V <sub>GS</sub> = 5.0 V, I <sub>D</sub> = 0.5 A, T <sub>.1</sub> = 25°C			105	120	1
	$V_{GS} = 5.0 \text{ V}, I_D = 0.5 \text{ A}, T_J = 150^{\circ}\text{C}$			185	210	1
	(Note 5)					
Source-Drain Forward On Voltage	$V_{GS} = 0 \text{ V}, I_S = 7.0 \text{ A}$	$V_{SD}$		1.05		V
SWITCHING CHARACTERISTICS (Note	5)			_		
Turn-ON Time (10% V <sub>IN</sub> to 90% I <sub>D</sub> )	$V_{GS} = 10 \text{ V}, V_{DD} = 12 \text{ V}$	t <sub>ON</sub>		20		μS
Turn-OFF Time (90% V <sub>IN</sub> to 10% I <sub>D</sub> )	$I_D = 2.5 \text{ A}, R_L = 4.7 \Omega$	t <sub>OFF</sub>		110		
Slew-Rate ON (70% V <sub>DS</sub> to 50% V <sub>DS</sub> )	$V_{GS} = 10 \text{ V}, V_{DD} = 12 \text{ V},$	-dV <sub>DS</sub> /dt <sub>ON</sub>		1.0		V/μs
Slew-Rate OFF (50% V <sub>DS</sub> to 70% V <sub>DS</sub> )	$R_L = 4.7 \Omega$	$dV_{DS}/dt_{OFF}$		0.4		
SELF PROTECTION CHARACTERISTIC		Note 4)				
Current Limit	$V_{DS} = 10 \text{ V}, V_{GS} = 5.0 \text{ V}, T_{J} = 25^{\circ}\text{C}$	I <sub>LIM</sub>	6.0	9.0	11	Α
	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 5.0 V, T <sub>J</sub> = 150°C (Note 5)		3.0	5.0	8.0	
	$V_{DS} = 10 \text{ V}, V_{GS} = 10 \text{ V}, T_{J} = 25^{\circ}\text{C}$		7.0	10.5	13	
	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 10 V, T <sub>J</sub> = 150°C (Note 5)		4.0	7.5	10	
Temperature Limit (Turn-off)	V <sub>GS</sub> = 5.0 V (Note 5)	T <sub>LIM(off)</sub>	150	180	200	°C
Thermal Hysteresis	V <sub>GS</sub> = 5.0 V	$\Delta T_{LIM(on)}$		15		1
Temperature Limit (Turn-off)	V <sub>GS</sub> = 10 V (Note 5)	T <sub>LIM(off)</sub>	150	165	185	1
Thermal Hysteresis	V <sub>GS</sub> = 10 V	$\Delta T_{LIM(on)}$		15		
GATE INPUT CHARACTERISTICS (Note	: 5)					
Device ON Gate Input Current	$V_{GS} = 5 \text{ V I}_{D} = 1.0 \text{ A}$	$I_{GON}$		50		μΑ
	V <sub>GS</sub> = 10 V I <sub>D</sub> = 1.0 A			400		1
Current Limit Gate Input Current	V <sub>GS</sub> = 5 V, V <sub>DS</sub> = 10 V	I <sub>GCL</sub>		0.05		mA
	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 10 V			0.4		
Thermal Limit Fault Gate Input Current	V <sub>GS</sub> = 5 V, V <sub>DS</sub> = 10 V	I <sub>GTL</sub>		0.22		mA
	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 10 V			1.0		
ESD ELECTRICAL CHARACTERISTICS	(T <sub>J</sub> = 25°C unless otherwise noted) (N	ote 5)				
Electro-Static Discharge Capability	Human Body Model (HBM)	ESD	4000			V
	Machine Model (MM)		400			1

- Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
   Fault conditions are viewed as beyond the normal operating range of the part.
   Not subject to production testing.

## **TYPICAL PERFORMANCE CURVES**

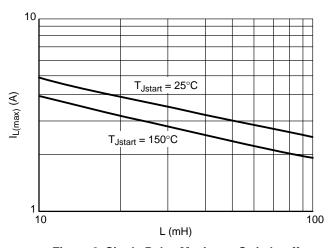


Figure 2. Single Pulse Maximum Switch-off Current vs. Load Inductance

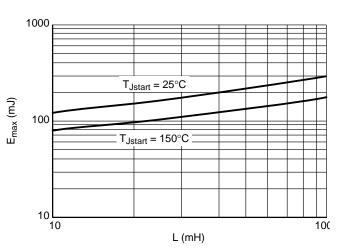


Figure 3. Single Pulse Maximum Switching Energy vs. Load Inductance

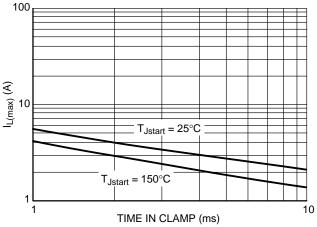


Figure 4. Single Pulse Maximum Inductive Switch-off Current vs. Time in Clamp

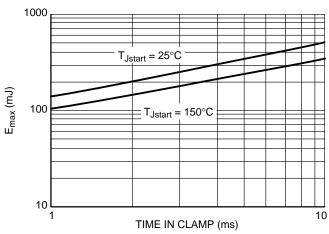


Figure 5. Single Pulse Maximum Inductive Switching Energy vs. Time in Clamp

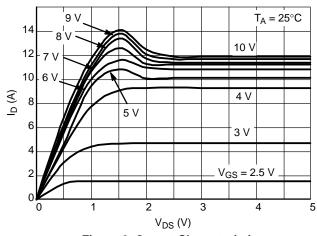


Figure 6. Output Characteristics

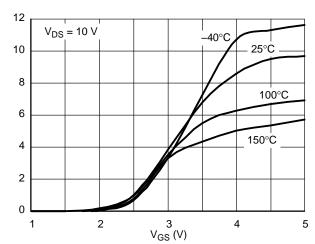


Figure 7. Transfer Characteristics

## **TYPICAL PERFORMANCE CURVES**

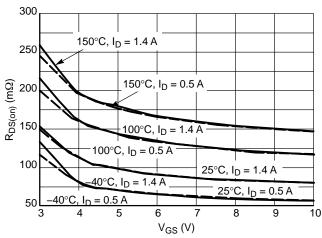


Figure 8. R<sub>DS(on)</sub> vs. Gate-Source Voltage

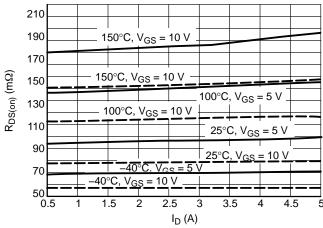


Figure 9. R<sub>DS(on)</sub> vs. Drain Current

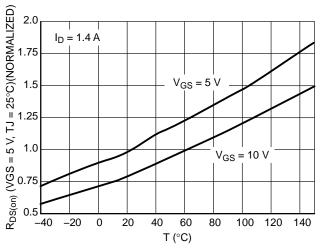


Figure 10. Normalized R<sub>DS(on)</sub> vs. Temperature

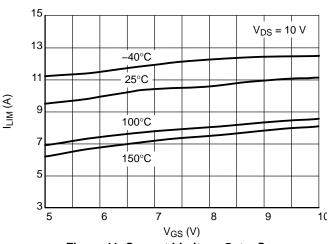


Figure 11. Current Limit vs. Gate-Source Voltage

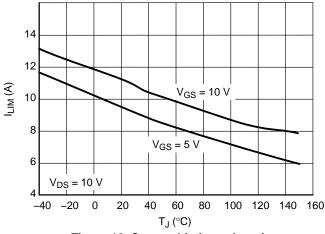


Figure 12. Current Limit vs. Junction Temperature

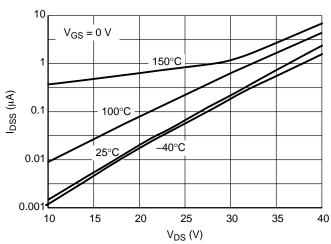


Figure 13. Drain-to-Source Leakage Current

## **TYPICAL PERFORMANCE CURVES**

V<sub>SD</sub> (V)

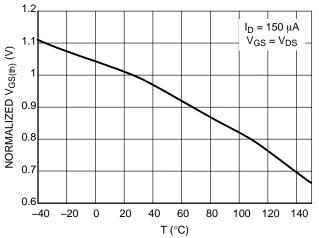


Figure 14. Normalized Threshold Voltage vs.
Temperature

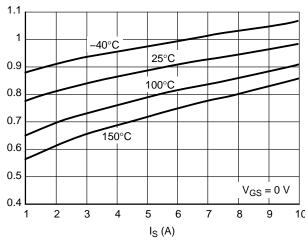


Figure 15. Body–Diode Forward Characteristics

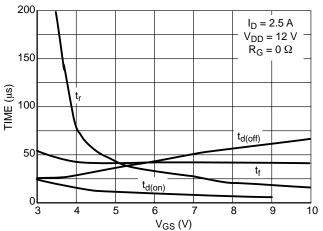


Figure 16. Resistive Load Switching Time vs.

Gate-Source Voltage

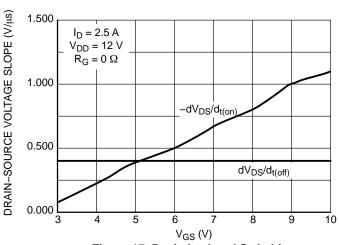


Figure 17. Resistive Load Switching
Drain-Source Voltage Slope vs. Gate-Source
Voltage

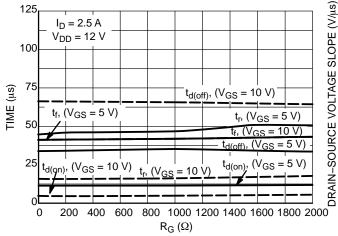


Figure 18. Resistive Load Switching Time vs.
Gate Resistance

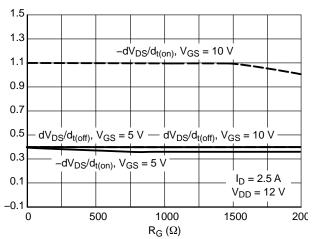


Figure 19. Drain-Source Voltage Slope during Turn On and Turn Off vs. Gate Resistance

## **TYPICAL PERFORMANCE CURVES**

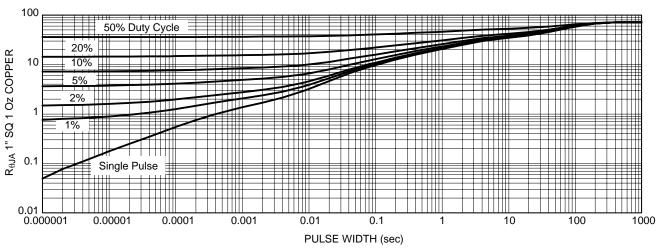


Figure 20. Transient Thermal Resistance

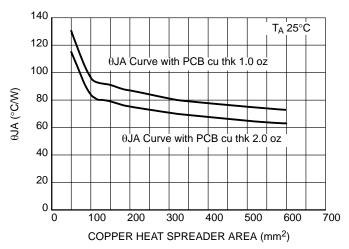


Figure 21. 0JA vs. Copper

## **TEST CIRCUITS AND WAVEFORMS**

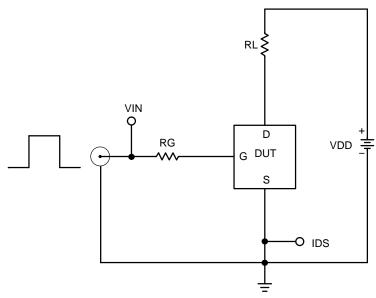


Figure 22. Resistive Load Switching Test Circuit

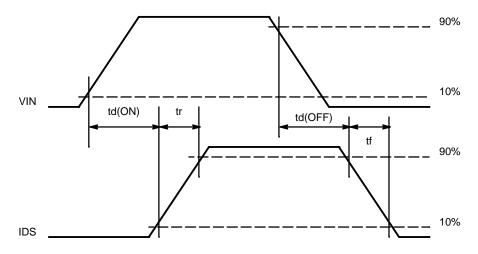


Figure 23. Resistive Load Switching Waveforms

# **TEST CIRCUITS AND WAVEFORMS**

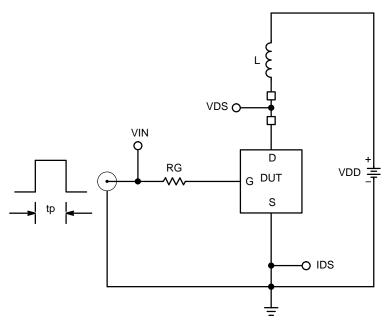


Figure 24. Inductive Load Switching Test Circuit

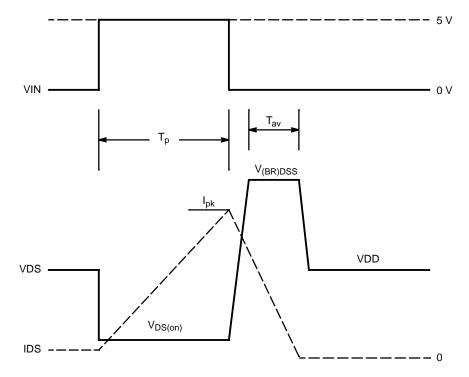


Figure 25. Inductive Load Switching Waveforms

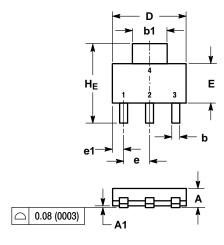
## **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NCV8405STT1G	SOT-223 (Pb-Free)	1000 / Tape & Reel
NCV8405ASTT1G	SOT-223 (Pb-Free)	1000 / Tape & Reel
NCV8405DTRKG	DPAK (Pb-Free)	2500 / Tape & Reel
NCV8405STT3G	SOT-223 (Pb-Free)	4000 / Tape & Reel
NCV8405ASTT3G	SOT-223 (Pb-Free)	4000 / Tape & Reel
NCV8405ADTRKG	DPAK (Pb-Free)	2500 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

## **PACKAGE DIMENSIONS**

## SOT-223 (TO-261) CASE 318E-04 ISSUE N





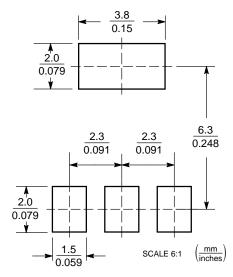
- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. 2. CONTROLLING DIMENSION: INCH.

	MILLIMETERS			INCHES		
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	1.50	1.63	1.75	0.060	0.064	0.068
A1	0.02	0.06	0.10	0.001	0.002	0.004
b	0.60	0.75	0.89	0.024	0.030	0.035
b1	2.90	3.06	3.20	0.115	0.121	0.126
С	0.24	0.29	0.35	0.009	0.012	0.014
D	6.30	6.50	6.70	0.249	0.256	0.263
E	3.30	3.50	3.70	0.130	0.138	0.145
е	2.20	2.30	2.40	0.087	0.091	0.094
e1	0.85	0.94	1.05	0.033	0.037	0.041
L	0.20			0.008	-	
L1	1.50	1.75	2.00	0.060	0.069	0.078
HE	6.70	7.00	7.30	0.264	0.276	0.287
θ		-			ı	

STYLE 3:
PIN 1. GATE
2. DRAIN
3. SOURCE
4. DRAIN

10° 0° 10°

## **SOLDERING FOOTPRINT\***

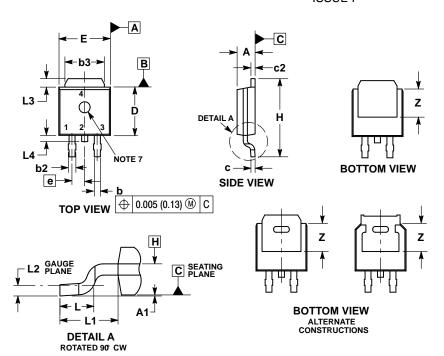


\*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

### PACKAGE DIMENSIONS

# **DPAK (SINGLE GAUGE)**

CASE 369C ISSUE F

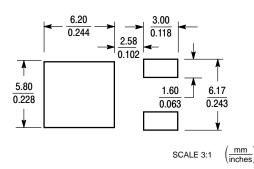


- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. CONTROLLING DIMENSION: INCHES.
- THERMAL PAD CONTOUR OPTIONAL WITHIN DI-
- MENSIONS b3, L3 and Z.

  4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE
- 5. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
  6. DATUMS A AND B ARE DETERMINED AT DATUM
- PLANE H.
  7. OPTIONAL MOLD FEATURE.

	INC	HES	MILLIN	IETERS	
DIM	MIN	MAX	MIN	MAX	
Α	0.086	0.094	2.18	2.38	
A1	0.000	0.005	0.00	0.13	
b	0.025	0.035	0.63	0.89	
b2	0.028	0.045	0.72	1.14	
b3	0.180	0.215	4.57	5.46	
С	0.018	0.024	0.46	0.61	
c2	0.018	0.024	0.46	0.61	
D	0.235	0.245	5.97	6.22	
E	0.250	0.265	6.35	6.73	
е	0.090	BSC	2.29 BSC		
Н	0.370	0.410	9.40	10.41	
L	0.055	0.070	1.40	1.78	
L1	0.114	REF	2.90	REF	
L2	0.020	BSC	0.51 BSC		
L3	0.035	0.050	0.89	1.27	
L4		0.040		1.01	
Z	0.155		3.93		

#### **SOLDERING FOOTPRINT\***



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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